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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/829,614	04/22/2004	Paul L. Falkenstein	NC 96,039	7320
	7590 07/01/200 ARCH LABORATOR	EXAMINER		
ASSOCIATE COUNSEL (PATENTS) CODE 1008.2 4555 OVERLOOK AVENUE, S.W. WASHINGTON, DC 20375-5320			DEHGHAN, QUEENIE S	
			ART UNIT	PAPER NUMBER
			1791	
			MAIL DATE	DELIVERY MODE
			07/01/2009	PAPER

Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.



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APPLICATION NO./ CONTROL NO.	FILING DATE	FIRST NAMED INVENTOR / PATENT IN REEXAMINATION	A	TTORNEY DOCKET NO.
10829614	4/22/2004	FALKENSTEIN ET AL.	NC 96,039	
			EXAMINER	
NAVAL RESEARCH LABORATORY ASSOCIATE COUNSEL (PATENTS)			QUEENIE DEHGHAN	
CODE 1008.2 4555 OVERLOOK AVENUE, S.W. WASHINGTON, DC 20375-5320			ART UNIT	PAPER

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Commissioner for Patents

20090629

The following is in response to the Order Returning Undocketed Appeal to Examiner, mailed June 25, 2009.

The Examiner inadvertently left out several references under section (8) for Evidence relied upon in the Examiner's answer dated December 3, 2007. The complete list includes:

Berkey et al. (US Patent Publication 2004/0050110), Siegmund (US 3,275,428), Fekety et al. (US 6,917,741), Sanghera et al. (US Patent Publication 2005/0025965), Large et al. (US Patent Publication 2005/0147366), Fajardo et al. (US 6,847,771), and Sato et al. (US 7,026,025).

The Examiner can be contacted regarding any inquiry concerning this communication at 571-272-8209.

/Eric Hug/ Primary Examiner, Art Unit 1791